

FORM PTO-892		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		SERIAL NO. 09/524,081	GROUP ART UNIT 2815	ATTACHMENT TO PAPER NO. 7	
		NOTICE OF REFERENCES CITED		APPLICANT(S) BAWOLEK ET AL.			

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*		DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
*	A	5,686,980	11/1997	Hirayama et al	349	110	
*	B	5,506,430	4/1996	Ohzu	257	292	
*	C	5,962,906	10/1999	Liu	257	432	
	D	5,576,239	11/1996	Hatano et al.	438	69	
*	E	6,137,634	10/2000	Li	359	619	
*	F	5,914,749	6/1999	Bawolek et al	348	273	
*	G	6,137,100	10/2000	Fossum et al.	250	280.1	
*	H	5,719,074	2/1998	Hawkins et al	438	70	
*	I	5,266,501	11/1993	Imai	438	60	
*	J	5,976,908	11/1999	Kwon et al.	438	69	
*	K	6,030,852	2/2000	Sano et al.	438	69	

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EXAMINER	DATE	
José R. Diaz	January 4, 2001	

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* A copy of this reference is not being furnished with this office action.
 (See Manual of Patent Examining Procedure, section 707.05(a).)

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*	A	5,514,888	5/1996	Sano et al.	257	232	
*	B	4,073,969	2/1978	Breazeale	427	75	
*	C	4,355,456	10/1982	Harnagel et al.	438	64	
*	D	6,002,145	12/1999	Niisoe	257	222	
*	E	5,986,297	11/1999	Guidash et al.	257	223	
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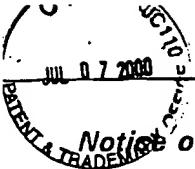
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 Notice of References Cited	Application No. 08/937,631	Applicant(s) BAWOLEK et al.	
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B	✓ 5,352,920	10/4/94	Morishite et al.	257	435
C	✓ 5,455,415	10/3/95	Yamada et al.	250	214.1
D	✓ 5,506,430	4/9/96	Ohzu	257	292
E	✓ 5,552,630	9/3/96	Miyake	257	435
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N	✓ 6-151797	5/31/94	Japan	Takamura	257	435
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